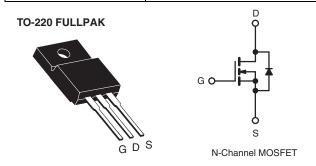


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Power MOSFET

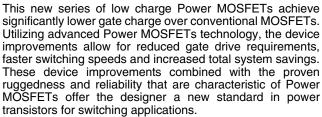
PRODUCT SUMMARY			
V _{DS} (V)	400		
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = 10 V	0.55	
Q _g (Max.) (nC)	39		
Q _{gs} (nC)	10		
Q _{gd} (nC)	19		
Configuration	Single		



FEATURES

- · Ultra Low Gate Charge
- · Reduced Gate Drive Requirement
- Enhanced 30 V V_{GS} Rating
- · Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s, f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- · Repetitive Avalanche Rated
- Lead (Pb)-free Available

DESCRIPTION



The TO-220 Fullpak eliminates the need for additional insulating hardware. The moulding compound used provides a high isolation capability and low thermal resistance between the tab and external heatsink.

ORDERING INFORMATION		
Package	TO-220 FULLPAK	
Lead (Pb)-free	IRFI740GLCPbF	
Leau (FD)-liee	SiHFI740GLC-E3	
SnPb	IRFI740GLC	
SIFD	SiHFI740GLC	

PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage	V_{DS}	400	V		
Gate-Source Voltage	V_{GS}	± 30	1 V		
Continuous Drain Current	V_{GS} at 10 V $T_C = 25 ^{\circ}C$	I-	5.7	А	
	$T_C = 100 ^{\circ}C$	I _D	3.6		
Pulsed Drain Current ^a	I _{DM}	23	1		
Linear Derating Factor		0.32	W/°C		
Single Pulse Avalanche Energy ^b	E _{AS}	310	mJ		
Repetitive Avalanche Current ^a	I _{AR}	5.7	Α		
Repetitive Avalanche Energy ^a	E _{AR}	4.0	mJ		
Maximum Power Dissipation	T _C = 25 °C	P_{D}	40	W	
Peak Diode Recovery dV/dtc	dV/dt	4.0	V/ns		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for 10 s		300 ^d	7	
Mounting Torque	6-32 or M3 screw		10	lbf ⋅ in	
	0-32 OF IVIS SCIEW		1.1	N · m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 50 V, starting T_J = 25 °C, L = 16 mH, R_G = 25 Ω , I_{AS} = 5.7 A (see fig. 12).
- c. $I_{SD} \leq$ 10 A, $dI/dt \leq$ 120 A/ μ s, $V_{DD} \leq$ V_{DS} , $T_{J} \leq$ 150 °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRFI740GLC, SiHFI740GLC

Vishay Siliconix



THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R _{thJA}	-	65	°C/W
Maximum Junction-to-Case (Drain)	R _{thJC}	-	3.1	C/VV

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		400	-	-	٧
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, I _D = 1 mA		0.76	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	$V_{DS} = V_{GS}, I_D = 250 \mu A$		-	4.0	V
Gate-Source Leakage	I _{GSS}		V _{GS} = ± 20 V		-	± 100	nA
Zero Gate Voltage Drain Current	lana	V _{DS} = 400 V, V _{GS} = 0 V		-	-	25	μΑ
Zero date voltage Brain Guirent	I _{DSS}	V _{DS} = 320 \	V _{DS} = 320 V, V _{GS} = 0 V, T _J = 125 °C		-	250	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 3.4 A ^b	-	-	0.55	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	$= 50 \text{ V}, I_D = 6.0 \text{ A}^b$	3.0	-	-	S
Dynamic							
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ f = 1.0 MHz, see fig. 5		-	1100	-	pF
Output Capacitance	C _{oss}			-	190	-	
Reverse Transfer Capacitance	C _{rss}			-	18	-	
Drain to Sink Capacitance	С		f = 1.0 MHz	-	12	-	
Total Gate Charge	Q_g			-	-	39	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$I_{\rm GS} = 10 \text{ V}$ $I_{\rm D} = 10 \text{ A}, V_{\rm DS} = 320 \text{ V},$ see fig. 6 and 13 ^b	-	-	10	nC
Gate-Drain Charge	Q_{gd}			-	-	19	
Turn-On Delay Time	t _{d(on)}		•		11	-	- ns
Rise Time	t _r	$V_{DD} = 200 \text{ V}, I_D = 10 \text{ A},$ $R_G = 9.1\Omega, R_D = 20 \Omega,$ see fig. 10^b		-	31	-	
Turn-Off Delay Time	t _{d(off)}			-	25	-	
Fall Time	t_f			-	20	-	
Internal Drain Inductance	L_{D}	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	الم
Internal Source Inductance	L _S			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	5.7	- A
Pulsed Diode Forward Current ^a	I _{SM}			-	-	23	
Body Diode Voltage	V _{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = 5.7 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	-	2.0	V
Body Diode Reverse Recovery Time	t _{rr}	T 05.00 !	40.4 all/at 400.4/. b	-	380	570	ns
Body Diode Reverse Recovery Charge	Q _{rr}	$T_J = 25 ^{\circ}\text{C}, I_F = 10 \text{A}, dI/dt = 100 \text{A}/\mu \text{s}^{\text{b}}$		-	2.8	4.2	μC
Forward Turn-On Time	t _{on}	Institute a la de	on is don	ninatad b	ıl andı	`\	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width $\leq 300~\mu s$; duty cycle $\leq 2~\%.$



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

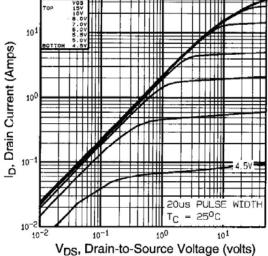


Fig. 1 - Typical Output Characteristics, $T_C = 25$ °C

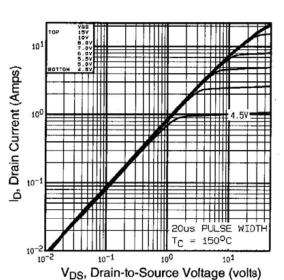


Fig. 2 - Typical Output Characteristics, T_C= 150 °C

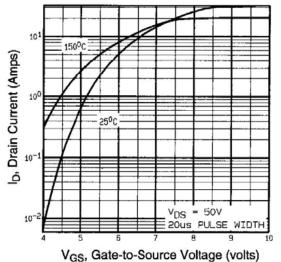


Fig. 3 - Typical Transfer Characteristics

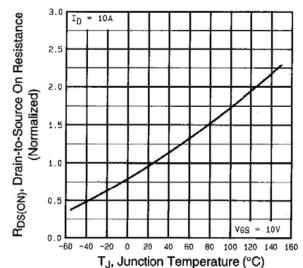


Fig. 4 - Normalized On-Resistance vs. Temperature

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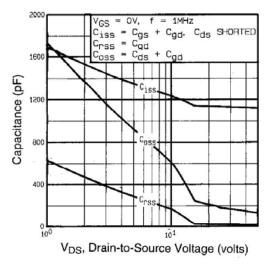
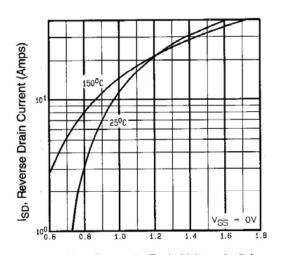


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage



V_{SD}, Source-to-Drain Voltage (volts)
Fig. 7 - Typical Source-Drain Diode Forward Voltage

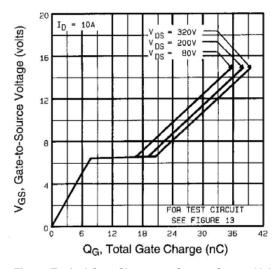
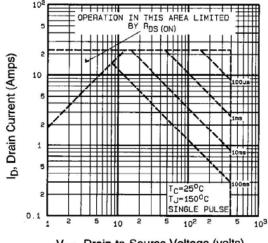


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



V_{DS}, Drain-to-Source Voltage (volts)

Fig. 8 - Maximum Safe Operating Area



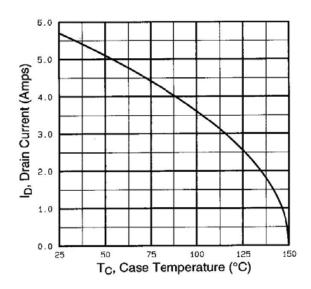


Fig. 9 - Maximum Drain Current vs. Case Temperature

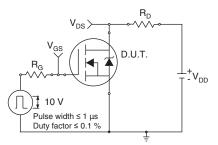


Fig. 10a - Switching Time Test Circuit

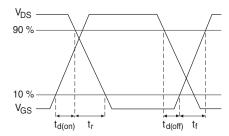
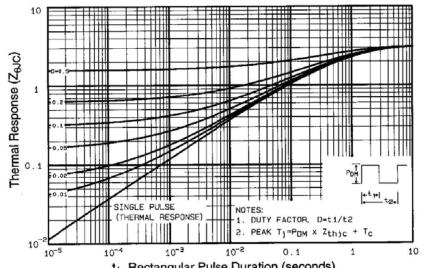


Fig. 10b - Switching Time Waveforms



t₁, Rectangular Pulse Duration (seconds)
Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

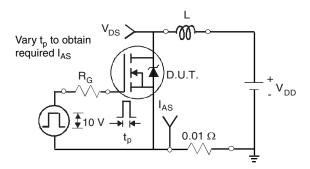


Fig. 12a - Unclamped Inductive Test Circuit

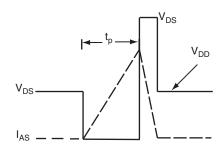


Fig. 12b - Unclamped Inductive Waveforms

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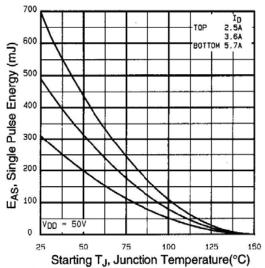


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

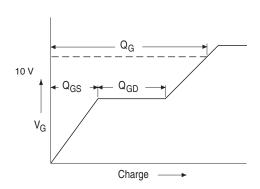
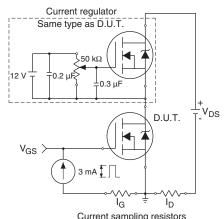


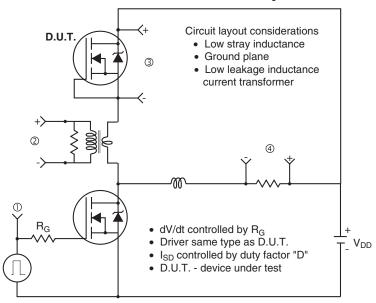
Fig. 13a - Basic Gate Charge Waveform

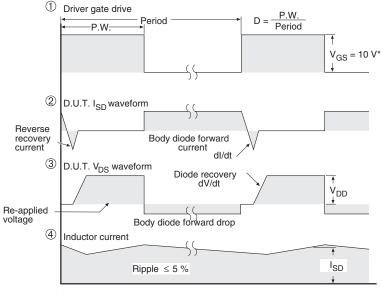


Current sampling resistors
Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit





* $V_{GS} = 5 V$ for logic level devices

Fig. 14 - For N-Channel

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